

Notice of References Cited	Application/Control No. 10/770,602		Applicant(s)/Patent Under Reexamination VOUTAY ET AL.	
	Examiner Donald E. McElheny, Jr.		Art Unit 2857	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,597,994	07-2003	Meek, Robert A.	702/16
*	B	US-2004/0210394	10-2004	Trappe et al.	702/14
*	C	US-6,651,006	11-2003	Trappe et al.	702/14
*	D	US-6,516,274	02-2003	Cheng et al.	702/14
*	E	US-6,223,126	04-2001	Neff et al.	702/16
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*	L	US-			
*	M	US-			

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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